## Test Report issued under the responsibility of:



## TEST REPORT EN 60947-2 Low-voltage switchgear and controlgear - Part 2: Circuit-breakers

Report Number:	03601-A-21D0101-S		
Date of issue:	2022-01-07		
Total number of pages	159 pages		
Name of Testing Laboratory preparing the Report	Suzhou Electrical Apparatus Science Research Institute Co., Ltd. (EETI)		
Applicant's name:	Zhejiang Tengen Smart Electrics Co., Ltd.		
Address:	No. 2777 West Zhongshan Road, Xiuzhou District, Jiaxing, Zhejiang Province, P.R.China.		
Test specification:			
Standard:	EN 60947-2:2017/A1:2020		
Test procedure:	CCA Scheme		
Non-standard test method:	N/A		
Test Report Form No:	EN60947_2J		
Test Report Form(s) Originator :	DEKRA Certification B:V, ADD FILE		
Master TRF:	Dated 2020-03-31		

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Test item description:	Mould	ed Case Circuit-Breaker
Trade Mark(s):	Tenge	n
Manufacturer:	No. 27	ng Tengen Smart Electrics Co., Ltd. 77 West Zhongshan Road, Xiuzhou District, Jiaxing, ng Province, P.R.China.
Model/Type reference:		NE-630M,TGM1NE-630H,TGMKE-630M,TGMKE-630H,
Old Product		E-630M,TGMGE-630H,TGMHE-630M,TGMHE-630H
Ratings:	See pa	age 10
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Responsible Testing Laboratory (as a	pplicab	le), testing procedure and testing location(s):
Testing Laboratory:		Suzhou Electrical Apparatus Science Research Institute Co., Ltd.(EETI)
Testing location/ address	:	No.7 Yonghe Street 怒而e Road, New District, Suzhou, China
Tested by (name, function, signature) :		Fang Gang(Team leader)
Approved by (name, function, signature):		Xu Jianlin(Supervisor)
Testing procedure: CTF Stage	1.	
Testing location/ address		
Tested by (name, function, signature)	:	
Approved by (name, function, signature):		
Testing procedure: CTF Stage 2	2:	
Testing location/ address	:	
Tested by (name + signature)	:	
Witnessed by (name, function, signat	ure).:	
Approved by (name, function, signatu	ıre) :	
	ing a fill	A - Constant and Constant Deputy and the subscription of the
Testing procedure: CTF Stage 3	3:	
Testing procedure: CTF Stage 4:		
Testing location/ address	:	
Tested by (name, function, signature)	:	
Witnessed by (name, function, signat	ure).:	
Approved by (name, function, signature) :		
Supervised by (name, function, signa	ture) :	

TRF No. EN60947\_2J

In case of alternative test programs for circuit bre following program is used: Programme 1 (three pole fully tested) Programme 2 (four pole fully tested) Alternative program not applicable	akers with a different number of poles, the
following program is used:	
☑ Programme 2 (four pole fully tested)	
Alternative program not applicable	
Tests performed (name of test and test clause):	Sample No.:##21#22 Mechanical properties of terminals 8.2.4
TEST SEQUENCE I	Clearances and creepage distances 7.1.4
Sample No.:#01#02	Insulating material:
8.3.3 General performance characteristics	Comparative tracking index 7.1.4 Resistance to abnormal heat and fire 8.2.1.1.1
TEST SEQUENCE II (Ics)	Sample specifications:
Sample No.:#03-#10	TGM1NE-630MP 630A 4P #01
3.3.4 Rated service short-circuit breaking capacity	TGM1NE-630M 630A 3P #02
	TGMHE-630M/3300 630A 3P
TEST SEQUENCE III (Icu)	#03#04#05#20#21#22 TGMHE-630M/3300 400A 3P #06#26
Sample No.:#11-#15	TGMKE-630M/3300 630A 3P
8.3.5 Rated ultimate short-circuit breaking capacity	#11#12#13#17#27
TEST SEQUENCE III (phase+N test)	TGMKE-630M/3300 400A 3P #14#18
Sample No.:#16	TGMGE-630H/3300 630A 3P #07#08#09
	TGMGE-630H/3300 400A 3P #10 TGMKE-630M/4300 630A 4P#15#16#19#23
TEST SEQUENCE IV	TGM1NE-630 with communication
Sample No.:#17#18	module+overload non-tripping accessory
3.3.6 Rated short-time withstand current	#24#25
	TGMHE-630M/3300 400A 3P #26
TEST SEQUENCE IV (phase+N test)	TGMKE-630M/3300 630A 3P #27
Sample No.:#19	
Annov C. Individual note short singuit test somuses	Remark:
Annex C -Individual pole short-circuit test sequence Sample No.:#26#27	
Jampie NU#20#21	This test report is based on test report 03601-A 21B0977-S issued on 2021-11-19, all the test
Annex F - Additional tests for circuit-breakers with	results are copied from the test report(except
electronic over-current protection	CTI test).
Sample No.:#20#23	
Annex N- Electromagnetic compatibility (EMC)	
Sample No.:#24#25	
Testing location:	
No.7 Yonghe Street, Binhe Road, New District, Suzho	bu,China
Summary of compliance with National Differences	

Statement concerning the uncertainty of the measurement systems used for the tests (may be required by the product standard or client)

 $\hfill\square$  Internal procedure used for type testing through which traceability of the measuring uncertainty has been established:

Procedure number, issue date and title:

Calculations leading to the reported values are on file with the NCB and testing laboratory that conducted the testing.

Statement not required by the standard used for type testing